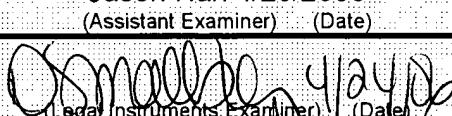
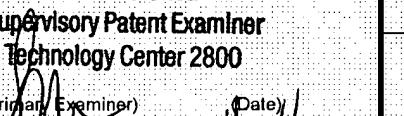


<i>Issue Classification</i>	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/665,316	ALBOU ET AL.
Examiner	Art Unit	
Jason M. Han	2875	

ISSUE CLASSIFICATION

ORIGINAL		CROSS REFERENCE(S)							
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
362	299	362	309	337	340	346	518	522	
INTERNATIONAL CLASSIFICATION									
F	2	1	V	7/00					
				/					
				/					
				/					
				/					
Jason Han 4/20/2006 (Assistant Examiner) (Date)					Sandra O'Shea Supervisory Patent Examiner Technology Center 2800 (Primary Examiner) (Date)				Total Claims Allowed: 19
 (Legal Instruments Examiner) (Date)					 O.G. Print Claim(s)				O.G. Print Fig.
					4/24/06 1				10b

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input checked="" type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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